



# BUK7514-55A

N-channel TrenchMOS standard level FET

Rev. 2 — 26 April 2011

Product data sheet

## 1. Product profile

### 1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

### 1.2 Features and benefits

- AEC Q101 compliant
- Low conduction losses due to low on-state resistance

### 1.3 Applications

- Automotive and general purpose power switching

### 1.4 Quick reference data

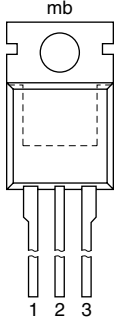
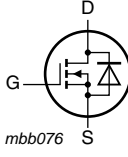
Table 1. Quick reference data

| Symbol                        | Parameter                                    | Conditions  | Min | Typ | Max | Unit       |
|-------------------------------|--|---|-----|-----|-----|------------|
| $V_{DS}$                      | drain-source voltage                         | $T_j \geq 25\text{ °C}; T_j \leq 175\text{ °C}$   | -   | -   | 55  | V          |
| $I_D$                         | drain current                                | $T_{mb} = 25\text{ °C}$   | -   | -   | 73  | A          |
| $P_{tot}$                     | total power dissipation                      |   | -   | -   | 166 | W          |
| <b>Static characteristics</b> |  |   |     |     |     |            |
| $R_{DS(on)}$                  | drain-source on-state resistance             | $V_{GS} = 10\text{ V}; I_D = 25\text{ A}; T_j = 25\text{ °C}$   | -   | 12  | 14  | m $\Omega$ |
| <b>Avalanche Ruggedness</b>   |  |   |     |     |     |            |
| $E_{DS(AL)S}$                 | non-repetitive drain-source avalanche energy | $I_D = 50\text{ A}; V_{sup} \leq 25\text{ V}; R_{GS} = 50\text{ }\Omega; V_{GS} = 5\text{ V}; T_{j(init)} = 25\text{ °C};$<br>unclamped | -   | -   | 125 | mJ         |



## 2. Pinning information

**Table 2. Pinning information**

| Pin | Symbol | Description                          | Simplified outline  | Graphic symbol  |
|-----|--------|--------------------------------------|---|---|
| 1   | G      | gate                                 |  |  |
| 2   | D      | drain                                |   |   |
| 3   | S      | source                               |   |   |
| mb  | D      | mounting base;<br>connected to drain |   |   |

**SOT78A (TO-220AB)**

## 3. Ordering information

**Table 3. Ordering information**

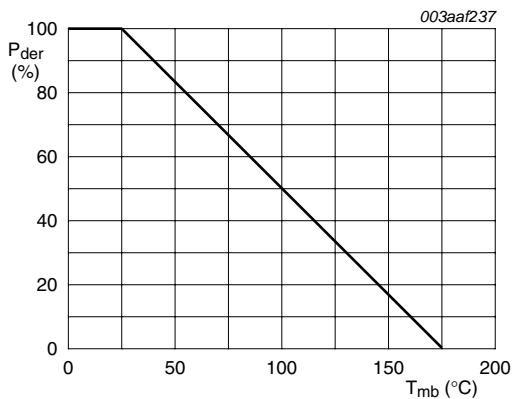
| Type number | Package  |   |         |
|-------------|----------|---|---------|
|             | Name     | Description   | Version |
| BUK7514-55A | TO-220AB | plastic single-ended package; heatsink mounted;<br>1 mounting hole; 3-lead TO-220AB | SOT78A  |

## 4. Limiting values

**Table 4. Limiting values**

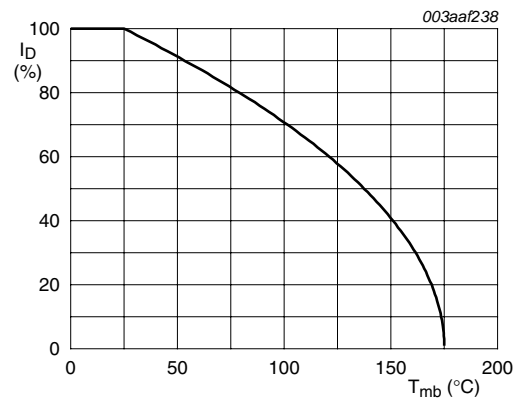
In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol                      | Parameter                                    | Conditions  | Min | Max | Unit |
|-----------------------------|--|---|-----|-----|------|
| $V_{DS}$                    | drain-source voltage                         | $T_j \geq 25\text{ °C}; T_j \leq 175\text{ °C}$   | -   | 55  | V    |
| $V_{DGR}$                   | drain-gate voltage                           | $R_{GS} = 20\text{ k}\Omega$  | -   | 55  | V    |
| $V_{GS}$                    | gate-source voltage                          |   | -20 | 20  | V    |
| $I_D$                       | drain current                                | $T_{mb} = 25\text{ °C}$   | -   | 73  | A    |
|                             |  | $T_{mb} = 100\text{ °C}$  | -   | 52  | A    |
| $I_{DM}$                    | peak drain current                           | $T_{mb} = 25\text{ °C};$ pulsed   | -   | 266 | A    |
| $P_{tot}$                   | total power dissipation                      | $T_{mb} = 25\text{ °C}$   | -   | 166 | W    |
| $T_{stg}$                   | storage temperature                          |   | -55 | 175 | °C   |
| $T_j$                       | junction temperature                         |   | -55 | 175 | °C   |
| <b>Source-drain diode</b>   |  |   |     |     |      |
| $I_S$                       | source current                               | $T_{mb} = 25\text{ °C}$   | -   | 73  | A    |
| $I_{SM}$                    | peak source current                          | pulsed; $T_{mb} = 25\text{ °C}$   | -   | 266 | A    |
| <b>Avalanche Ruggedness</b> |  |   |     |     |      |
| $E_{DS(AL)S}$               | non-repetitive drain-source avalanche energy | $I_D = 50\text{ A}; V_{sup} \leq 25\text{ V}; R_{GS} = 50\text{ }\Omega;$<br>$V_{GS} = 5\text{ V}; T_{j(init)} = 25\text{ °C};$ unclamped | -   | 125 | mJ   |



$$P_{der} = \frac{P_{tot}}{P_{tot(25^\circ\text{C})}} \times 100\%$$

**Fig 1. Normalized total power dissipation as a function of mounting base temperature**



$$I_{der} = \frac{I_D}{I_{D(25^\circ\text{C})}} \times 100\%$$

$V_{GS} \geq 5\text{ V}$

**Fig 2. Normalized continuous drain current as a function of mounting base temperature**

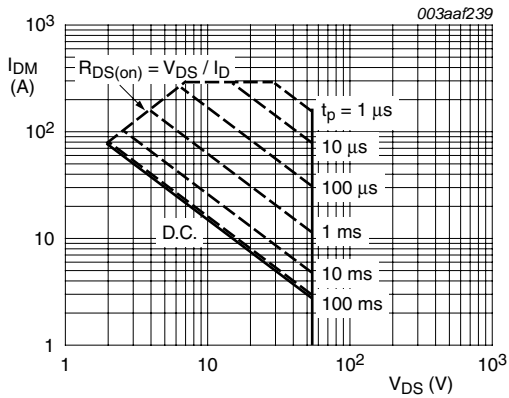


Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

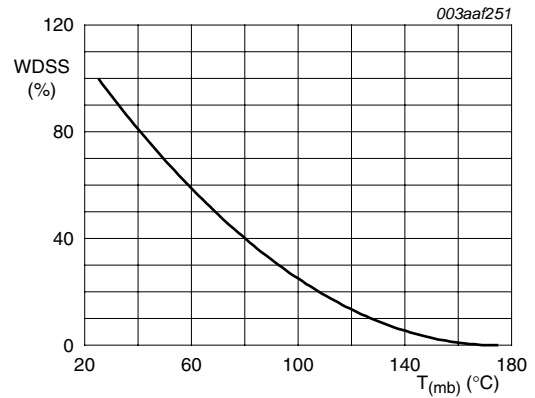


Fig 4. Normalised drain-source non-repetitive avalanche energy as a function of mounting-base temperature

### 5. Thermal characteristics

Table 5. Thermal characteristics

| Symbol         | Parameter   | Conditions  | Min | Typ | Max | Unit |
|----------------|---|-------------|-----|-----|-----|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base |             | -   | -   | 0.9 | K/W  |
| $R_{th(j-a)}$  | thermal resistance from junction to ambient       | in free air | -   | 60  | -   | K/W  |

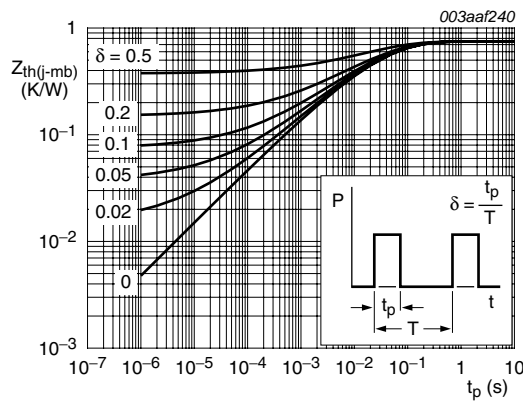
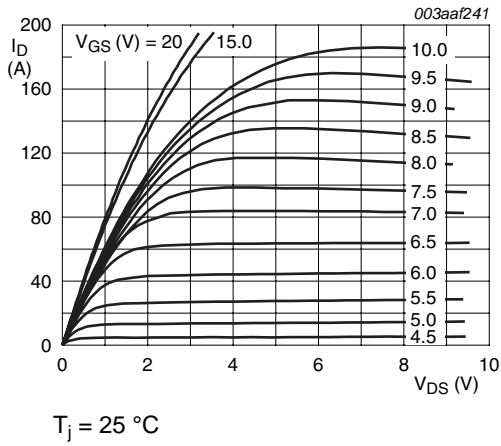


Fig 5. Transient thermal impedance from junction to mounting base as a function of pulse duration

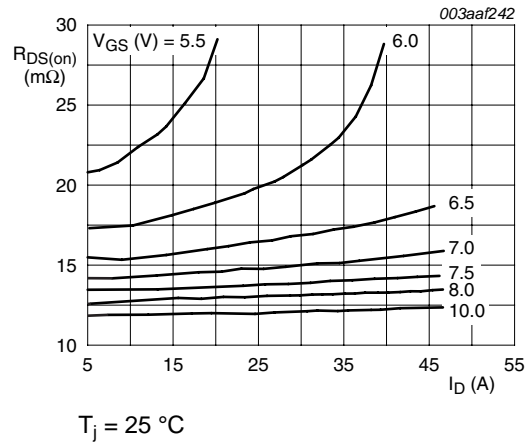
## 6. Characteristics

Table 6. Characteristics

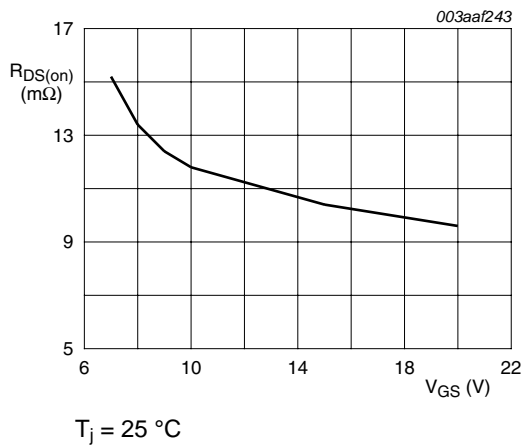
| Symbol                         | Parameter                        | Conditions   | Min | Typ  | Max  | Unit          |
|--------------------------------|----------------------------------|--|-----|------|------|---------------|
| <b>Static characteristics</b>  |                                  |  |     |      |      |               |
| $V_{(BR)DSS}$                  | drain-source breakdown voltage   | $I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$   | 55  | -    | -    | V             |
|                                |                                  | $I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ }^\circ\text{C}$  | 50  | -    | -    | V             |
| $V_{GS(th)}$                   | gate-source threshold voltage    | $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ }^\circ\text{C}$   | 2   | 3    | 4    | V             |
|                                |                                  | $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ }^\circ\text{C}$  | 1   | -    | -    | V             |
|                                |                                  | $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ }^\circ\text{C}$  | -   | -    | 4.4  | V             |
| $I_{DSS}$                      | drain leakage current            | $V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$   | -   | 0.05 | 10   | $\mu\text{A}$ |
|                                |                                  | $V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ }^\circ\text{C}$  | -   | -    | 500  | $\mu\text{A}$ |
| $I_{GSS}$                      | gate leakage current             | $V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$   | -   | 2    | 100  | nA            |
|                                |                                  | $V_{GS} = -20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$  | -   | 2    | 100  | nA            |
| $R_{DS(on)}$                   | drain-source on-state resistance | $V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 175 \text{ }^\circ\text{C}$  | -   | -    | 28   | m $\Omega$    |
|                                |                                  | $V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ }^\circ\text{C}$   | -   | 12   | 14   | m $\Omega$    |
| <b>Dynamic characteristics</b> |                                  |  |     |      |      |               |
| $C_{iss}$                      | input capacitance                | $V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz}; T_j = 25 \text{ }^\circ\text{C}$  | -   | 1848 | 2464 | pF            |
| $C_{oss}$                      | output capacitance               |  | -   | 421  | 506  | pF            |
| $C_{rss}$                      | reverse transfer capacitance     |  | -   | 231  | 317  | pF            |
| $t_{d(on)}$                    | turn-on delay time               | $V_{DS} = 30 \text{ V}; R_L = 1.2 \text{ } \Omega; V_{GS} = 5 \text{ V}; R_{G(ext)} = 10 \text{ } \Omega; T_j = 25 \text{ }^\circ\text{C}$ | -   | 17   | 26   | ns            |
| $t_r$                          | rise time                        |  | -   | 79   | 119  | ns            |
| $t_{d(off)}$                   | turn-off delay time              |  | -   | 57   | 80   | ns            |
| $t_f$                          | fall time                        |  | -   | 51   | 71   | ns            |
| $L_D$                          | internal drain inductance        | measured from drain lead 6 mm from package to centre of die; $T_j = 25 \text{ }^\circ\text{C}$   | -   | 4.5  | -    | nH            |
|                                |                                  | measured from contact screw on tab to centre of die; $T_j = 25 \text{ }^\circ\text{C}$   | -   | 3.5  | -    | nH            |
| $L_S$                          | internal source inductance       | measured from source lead to source bond pad; $T_j = 25 \text{ }^\circ\text{C}$  | -   | 7.5  | -    | nH            |
| <b>Source-drain diode</b>      |                                  |  |     |      |      |               |
| $V_{SD}$                       | source-drain voltage             | $I_S = 25 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$  | -   | 0.85 | 1.2  | V             |
|                                |                                  | $I_S = 73 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$  | -   | 1.1  | -    | V             |
| $t_{rr}$                       | reverse recovery time            | $I_S = 73 \text{ A}; dI_S/dt = -100 \text{ A}/\mu\text{s}; V_{GS} = -10 \text{ V}; V_{DS} = 30 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$ | -   | 54   | -    | ns            |
| $Q_r$                          | recovered charge                 |  | -   | 0.12 | -    | $\mu\text{C}$ |



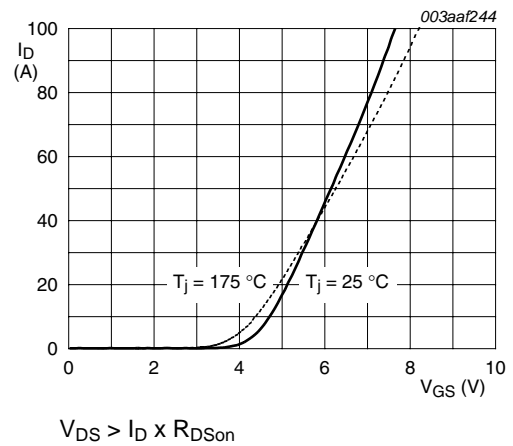
**Fig 6. Output characteristics: drain current as a function of drain-source voltage; typical values**



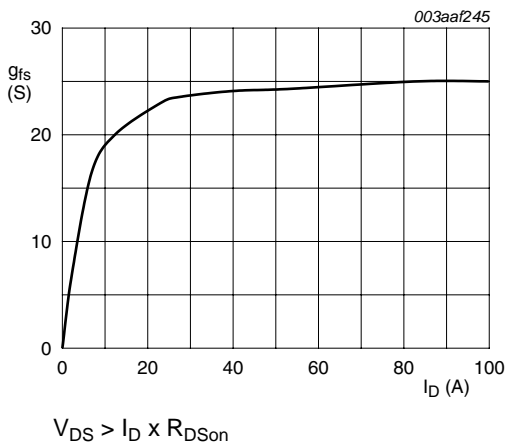
**Fig 7. Drain-source on-state resistance as a function of drain current; typical values**



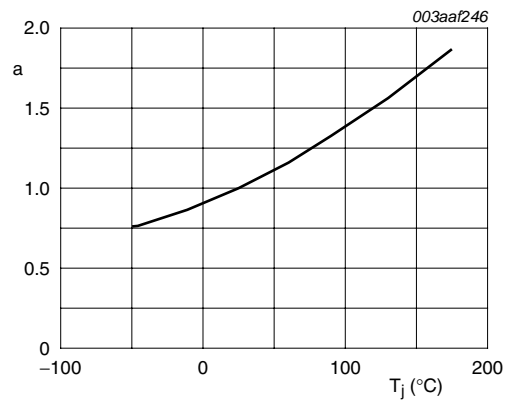
**Fig 8. Drain-source on-state resistance as a function of gate-source voltage; typical values**



**Fig 9. Transfer characteristics: drain current as a function of gate-source voltage; typical values**

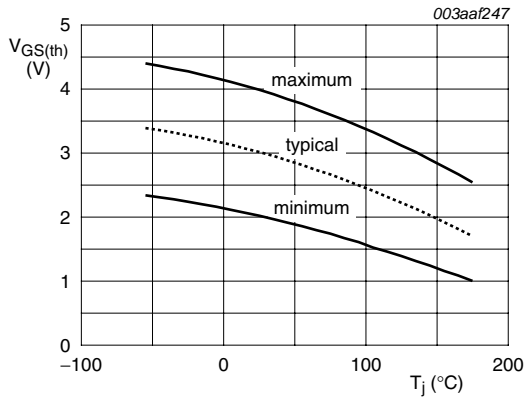


**Fig 10. Forward transconductance as a function of drain current; typical values**



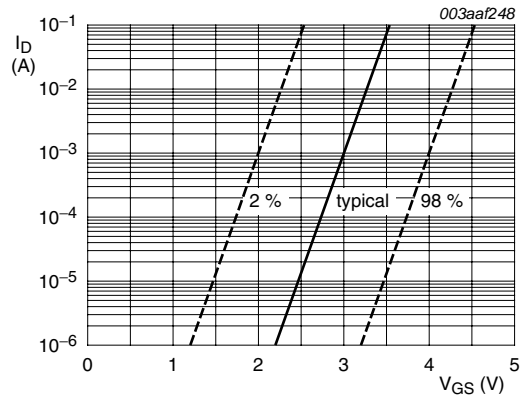
**Fig 11. Normalized drain-source on-state resistance factor as a function of junction temperature**

$$a = \frac{R_{DS(on)}}{R_{DS(on)@25^\circ\text{C}}}$$



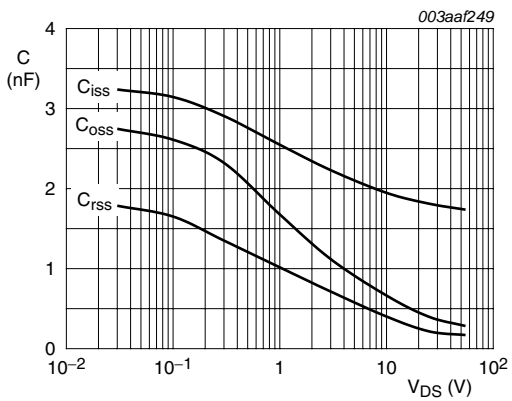
$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$

**Fig 12. Gate-source threshold voltage as a function of junction temperature**



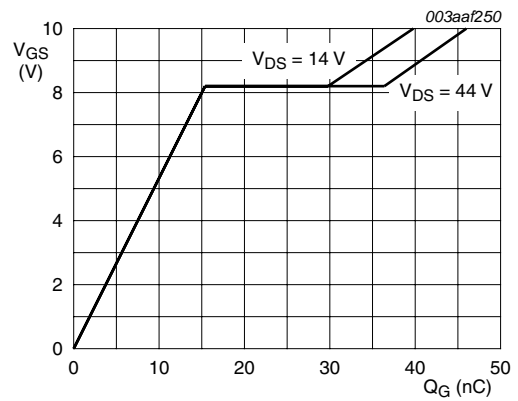
$T_j = 25 \text{ °C}; V_{DS} = V_{GS}$

**Fig 13. Sub-threshold drain current as a function of gate-source voltage**



$V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$

**Fig 14. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values**



$T_j = 25 \text{ °C}; I_D = 50 \text{ A}$

**Fig 15. Gate-source voltage as a function of gate charge; typical values**

**7. Package outline**

Plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB

SOT78A

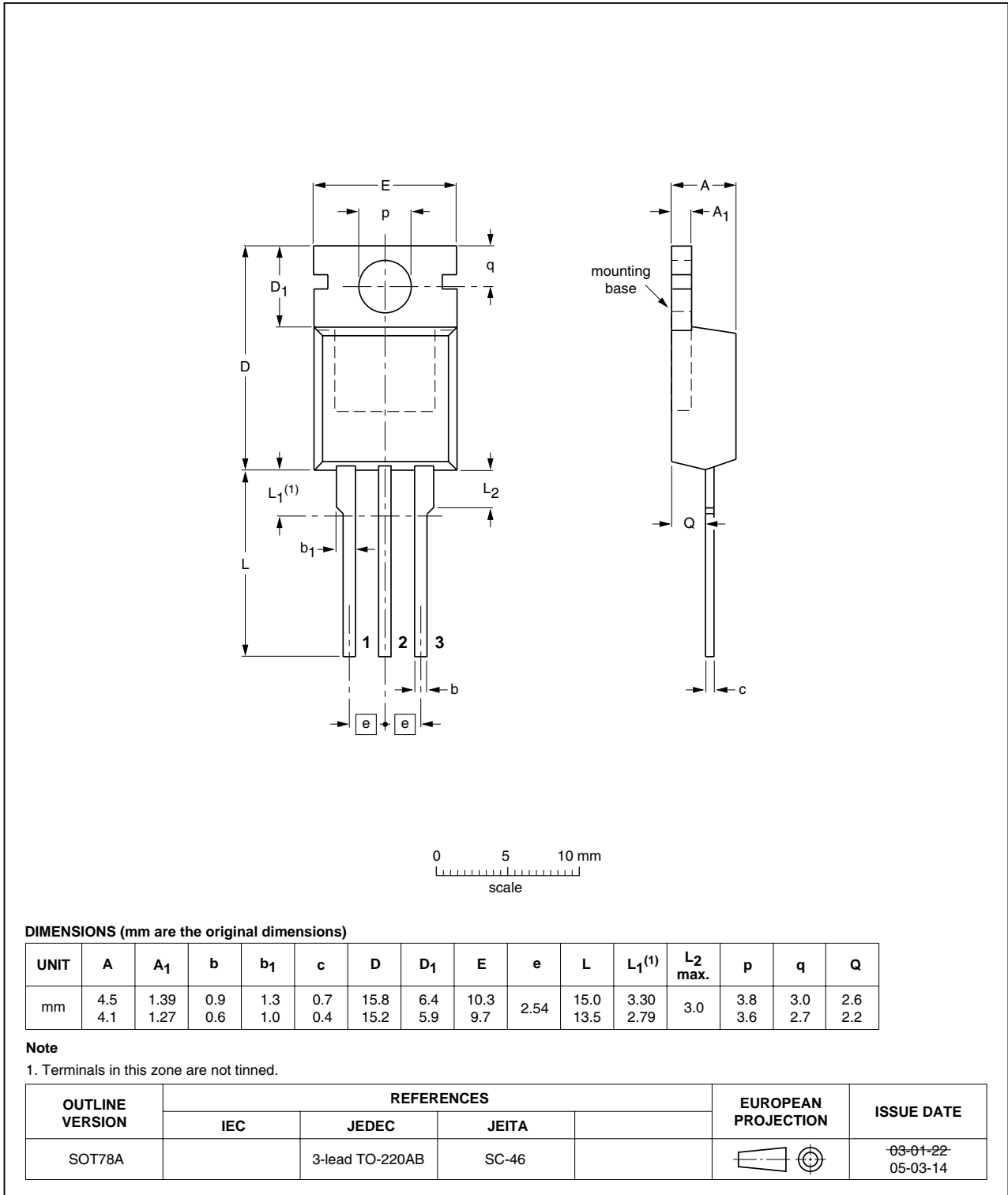


Fig 16. Package outline SOT78A (TO-220AB)

## 8. Revision history

Table 7. Revision history

| Document ID        | Release date | Data sheet status     | Change notice | Supersedes   |
|--------------------|--------------|-----------------------|---------------|--|
| BUK7514-55A v.2    | 20110426     | Product data sheet    | -             | BUK7514_7614-55A_1   |
| Modifications:     |              |                       |               |  |
|                    |              |                       |               | <ul style="list-style-type: none"><li>• The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li><li>• Legal texts have been adapted to the new company name where appropriate.</li><li>• Type number BUK7514-55A separated form data sheet BUK7514_7614-55A_1.</li></ul> |
| BUK7514_7614-55A_1 | 20000701     | Product specification | -             | -  |

## 9. Legal information

### 9.1 Data sheet status

| Document status <a href="#">[1]</a> <a href="#">[2]</a> | Product status <a href="#">[3]</a> | Definition  |
|---|------------------------------------|---|
| Objective [short] data sheet                            | Development                        | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet                          | Qualification                      | This document contains data from the preliminary specification.                       |
| Product [short] data sheet                              | Production                         | This document contains the product specification.                                     |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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